2nd Global COE International Symposium Electronic Devices Innovation EDIS2009 -- Series Workshop --

Division of Electrical, Electronic and Information Engineering (EEIE), Graduate School of Engineering, Osaka University

The global COE program "Center for Electronic Devices Innovation" started in Osaka University in 2007. We invite you to attend the second International Symposium of the COE program in December 2009 to February 2010. The symposium will focus on the research challenges for future electronic devices and provide an opportunity for scientists and engineers working in various fields of electronic devices. You are cordially invited to participate in the symposium.

Series Workshop

Workshop 1 The International Workshop on Terahertz Technology 2009 (TeraTech '09)

Date: December 2, 2009

Venue: Nakanoshima-Center, Osaka University, Osaka, Japan Organizer: Prof. M. Tonouchi and Assoc. Prof. M. Yoshimura

Workshop 2 Global Workshop on Organic Thin-Film Solar Cell

Date: December 7, 2009

Venue: Icho Kaikan, Osaka University, Suita, Osaka, Japan

Organizer: Assoc. Prof. A. Fujii

Workshop 3 Frontier Workshop for Advanced Optical Communications

Date: December 11-12, 2009

Venue: Machikaneyama Kaikan, Osaka University, Toyonaka, Osaka, Japan

Organizer: Assist. Prof. S. Hisatake

Workshop 4 Advances in Neuroengineering III

Date: February 1-2, 2010

Venue: Icho Kaikan, Osaka University, Suita, Osaka, Japan

Organizer: Assist. Prof. H. Okuno

Workshop 5 Applications of Atomic Force Microscopy

Date: January 14-15, 2010

Venue: Hotel Hankyu Expo-park, Suita, Osaka, Japan

Organizer: Assoc. Prof. M. Abe

Workshop 6 Japan-UK Workshop - Novel Phenomena and Techniques

in Semiconductor Nanostructures

Date: January 22, 2010

Venue: Faculty House University of Tokyo, Tokyo, Japan

Organizer: Assoc. Prof. N. Mori

Plenary and Keynote Lecturers (confirmed as of November 2009)

[Workshop1]

Plenary Talk Hiromasa Itoh (Riken, Japan)

Keynote Xi-Cheng Zhang (Rensselaer Polytech. Inst., USA)

Jerome Faist (ETH Zurich, Switzerland)

[Workshop2]

Keynote Katsumi Yoshino (Shimane Institute for Industrial Technology, Japan)

[Workshop4]

Special Lecture Mitsuo Kawato (Director of ATR Computational Neuroscience Laboratories, Japan)

Updated information and Invited lecturers of each workshop are available at EDIS2009 web site.

Call for presentation

Some workshop will welcome oral or poster presentation.

Detailed informations are available at the EDIS2009 web site.

Important Date

Deadlines of Paper submission and Registration will be determined by each symposium.

Please check at EDIS2009 web site

Registration and Accommodations

Instructions of Registration and Accommodations are available at the EDIS2009 web site.

The registration fee will be free except for symposium reception and extra copies of abstracts.

Reception

Reception party will be held in the evening during the workshop.

Reception fee will be different on each workshop. Please check at EDIS2009 web site

Location

Edis2009 Series Workshop will be held at

Suita Campus and Toyonaka Campus of Osaka University,

Nakanoshima Center of Osaka University, and

Hotel Hankyu Expo-park near Suita Campus

Both campus and Hotel Hankyu Expo-park are located in the north part of Osaka.

Nakanoshima-Center is located near the center of Osaka City

Detailed access maps are available at EDIS2009 web site.

Organizing Committee:

Chairperson: K. Taniguchi

Members: T. Ise, T. Ito, M. Kuzuhara, M. Katayama, T. Sugino, M. Tonouchi, Y. Kitaoka

H. Itozaki, R. Kodama, K. Kitayama, K. Inoue, T. Suhara, M. Kondow, M. Ozaki,

M. Yoshimura, Y. Ohmori, N. Mori, M. Abe, T. Matsuoka and H. Okuno

Sponsored by

The Global COE Program "Center for Electronic Devices Innovation"

Co-sponsored by

Graduate School of Engineering, Osaka University

Web site of EDIS 2009:

Updated information on the symposium is

presented in the web site

http://www.eei.eng.osaka-u.ac.jp/gcoe/EDIS2009/

Contact:

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